

**Search Notes**

Application/Control No.

10/623,418

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

OHKAWA, NARUMI

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	302	2/28/2007	NT
348	308	2/28/2007	NT
257	291	2/14/2008	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Updated PGPUB text search - see search history printout		2/14/2008	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) Text search - see search history printout	10/1/2007	NT
348/294-324 (text search - see search history printout)	2/28/2007	NT
257/290-292 (text search - see search history printout)	3/1/2007	NT
250/208.1 (text search - see search history printout)	3/1/2007	NT
Search all classes - see search history printout	3/1/2007	NT
Inventorship search - see search history printout	10/1/2007	NT
Updated text search on all classes	2/14/2008	NT